Search Notes

	Application/Control No.	Applicant(s)/Patent Under Reexamination	
	10572752	NAKAMURA ET AL.	
	Examiner	Art Unit	
	Jennifer F Hu	4158	

SEARCHED					
Class	Subclass	Date	Examiner		
343	788	11/13/2007	Jennifer F. Chang		
343	787	11/19/2008	Jennifer F. Chang		

SEARCH NOTES			
Search Notes	Date	Examiner	
EAST Search History	11/13/2007	Jennifer F. Chang	
Inventor Search in eDAN	11/13/2007	Jennifer F. Chang	
EAST Search History	6/5/2008	Jennifer F. Chang	
Eadt search:343/711-713, text (see search printout)	6/17/2010	T.D	

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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